

Search Notes

Application/Control No.

10/066,173

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

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Art Unit

2668

SEARCHED

Class	Subclass	Date	Examiner
370	204	3/7/2006	HN
	205		
	212		
	213		
	214		
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375	239		
	237		
	238		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	3/7/2006	HN